

CHAPTER 2

2.1

From Fig. (2.2)

For p-type Si,

$$N_A = 1.5 \times 10^{16} \text{ atoms/cm}^3$$

For n-type Si,

$$N_D = 6 \times 10^{15} \text{ atoms/cm}^3$$

2.2

$$R_{\square} = \frac{e}{T} = 1 \frac{\Omega \cdot \text{cm}}{5 \mu\text{m}} = \frac{1 \Omega \cdot \text{cm}}{5 \times 10^4 \text{ cm}} \\ = 2000 \Omega/\square$$

2.3

The doping profile has the form

$$N_D(x) = N_{D0} \exp\left(-\frac{x}{L}\right)$$

The first step is to determine

N_{D0} and L . Since at $x=0$,

$$N_D(x) = 10^{17} \text{ cm}^{-3}, \text{ then}$$

$$N_{D0} = 10^{17} \text{ cm}^{-3}$$

$$\text{At } x = 0.5 \mu\text{m}, N_D(x) = \frac{1}{e} N_D(0)$$

$$\therefore N_{D0} e^{-1} = N_{D0} \exp\left(-\frac{0.5 \mu\text{m}}{L}\right)$$

$$\therefore L = 0.5 \mu\text{m}$$

Thus,

$$N_D(x) = 10^{17} \exp\left(-\frac{x}{0.5 \mu\text{m}}\right)$$

The junction will exist at the point where the net doping

$$N_D(x) - N_A(x) = 0$$

$$\therefore 10^{17} \exp\left(-\frac{x_j}{0.5 \mu\text{m}}\right) = 10^{15}$$

$$\therefore x_j = 0.5 \mu\text{m} \ln \frac{10^{17}}{10^{15}} = 2.34 \mu\text{m}$$

The sheet resistance is given by :

$$R_{\square} = \left[q \bar{A}_n \int_0^{x_j} [N_D(x) - N_A(x)] dx \right]^{-1}$$

Since the effective doping is $N_D(x) - N_A(x)$

$$\therefore q \left[800 \frac{\text{cm}^2}{\text{V} \cdot \text{sec}} \right] \int_0^{2.34 \mu\text{m}} [10^{17} e^{-\frac{x}{0.54 \mu\text{m}}} - 10^{15}] dx \\ = q \left[800 \frac{\text{cm}^2}{\text{V} \cdot \text{sec}} \right] \left[[-0.5 \times 10^{11} - 2.3 \times 10^{10}] + 0.5 \times 10^{13} \right] \\ = 1.6 \times 10^{-19} \times 800 \times 4.72 \times 10^{12} \\ = 1.6 \times 8 \times 4.72 \times 10^{-5} \\ \therefore R_{\square} = [6.04 \times 10^{-4}]^{-1} = 1655 \Omega/\square$$

2.4

For the resistor $\frac{L}{W} = \frac{200 \mu\text{m}}{5 \mu\text{m}} = 40$

Base-diffused

$$R = 40 \times 100 \Omega/\square = 4 \text{ k}\Omega$$

Emitter-diffused

$$R = 40 \times 5 \Omega/\square = 200 \Omega$$

Pinch

$$R = 40 \times 5 \text{ k}\Omega/\square = 200 \text{ k}\Omega$$

2.5

From (2.17), for an npn-transistor,

$$Q_B = \frac{A \bar{D}_n q N_i^2}{I_c} \exp\left(\frac{V_{BE}}{V_T}\right)$$

For $V_{BE} = 520 \text{ mV}$,

$$Q_B = \frac{(10^{-4} \text{ cm}^2)(13 \frac{\text{cm}^2}{\text{sec}})(1.6 \times 10^{19})(2 \times 10^{20})}{10^{-5}} e^{(520/26)} \\ = 2.02 \times 10^{12} \text{ atoms/cm}^2$$

For $V_{BE} = 580 \text{ mV}$, same expression

$$\text{gives : } Q_B = 2 \times 10^{13} \text{ atoms/cm}^2$$

For $Q_B = 2.02 \times 10^{12}$

$$R_D = [q \bar{M}_P Q_B]^{-1}$$

$$= [(1.6 \times 10^{19})(150 \frac{\text{cm}^2}{\text{V-sec}})(2.02 \times 10^{12})]^{-1}$$

$$= (485 \times 10^{17})^{-1} = 21 \text{ k}\Omega/\square$$

2.6

(a) Series base R :

Emitter periphery adjacent to a base contact is :

$$p = 4 \times 40 \mu\text{m} = 160 \mu\text{m}$$

Distance from base contact to emitter is : $10 \mu\text{m}$

$$\therefore R_B = R_D \left(\frac{10}{160} \right) = 100 \Omega \left(\frac{1}{16} \right)$$

$$= 6.2 \Omega$$

(b) Series collector resistance :

For each of two emitters the effective buried layer dimensions are :

$$W_{BL} = (W + 2T) = 20 \mu\text{m} + 2(10 \mu\text{m})$$

$$= 40 \mu\text{m}$$

$$L_{BL} = (L + 2T) = 40 \mu\text{m} + 2(10 \mu\text{m})$$

$$= 60 \mu\text{m}$$

Using (2.18),

$$a = \left(\frac{20}{40} \right)^{-1}, \quad b = \left(\frac{40}{60} \right)^{-1}$$

$$2R_C = \frac{(5 \Omega\text{-cm})(10 \mu\text{m})}{(20 \mu\text{m})(40 \mu\text{m})} \ln \frac{2/1.5}{0.5}$$

$$= 360 \Omega$$

$$\therefore R_C = 180 \Omega$$

$$Y_{C2} = R_{BL} \left(\frac{L}{W} \right) = 20 \frac{\Omega}{\mu\text{m}} \left(\frac{40}{140} \right) = 5.7 \Omega$$

Y_{C3} : for buried layer

$$L_{eff} = 140 \mu\text{m}$$

$$W_{eff} = 14 \mu\text{m} + 2T = 34 \mu\text{m}$$

For top N^+ : $L = 140 \mu\text{m}$

$$W = 14 \mu\text{m}$$

$$\therefore a = \frac{34}{14} = 2.43; \quad b = 1$$

$$\therefore Y_{C3} = \frac{(5 \Omega\text{-cm})(10 \mu\text{m})}{(140 \mu\text{m})(14 \mu\text{m})} \ln \frac{2.43}{2.43 - 1}$$

$$= 158 \Omega$$

$$\therefore R_C = 158 + 180 + 5.7 = 344 \Omega$$

$$(c) C_{jc} = (A_{bottom} + A_{sidewall}) C_{jc}/\text{area}$$

$$= [(140 \mu\text{m})(60 \mu\text{m}) + \frac{\pi \times 3 \mu\text{m}}{2} (280 \mu\text{m} + 120 \mu\text{m})] \times 10^{-4} \text{ PF}/(\mu\text{m})^2$$

$$= (8400 + 1865) \times 10^{-4}$$

$$= 1.03 \text{ pF}$$

$$(d) C_{je} \approx (C_{je bottom} + C_{je sidewall})$$

$$= 2 [A_{bottom} + A_{sidewall}] C_{je}/\text{area}$$

$$= 2 [(20 \mu\text{m})(40 \mu\text{m}) + \frac{\pi \times 2 \mu\text{m}}{2} (40 \mu\text{m} + 80 \mu\text{m})] \times 10^{-4} \text{ PF}/(\mu\text{m})^2$$

$$= 2.4 \text{ pF}$$

$$(e) C_{substrate} = C_{sidewall} + C_{epi-sub}$$

$$+ C_{BL-sub}$$

$$C_{sidewall} = \frac{\pi}{2} \times (17 \mu\text{m}) [175 \mu\text{m} \times 2 + 140 \mu\text{m} \times 2] \times 10^{-4} \text{ PF}/(\mu\text{m})^2$$

$$= 1.6 \text{ pF}$$

$$C_{epi-sub} = (175 \times 140 - 85 \times 126) \times 10^{-4} \text{ PF}/(\mu\text{m})^2$$

$$= 1.4 \text{ pF}$$

$$C_{BL-sub} = (85 \times 126) \times 3.3 \times 10^{-4} = 3.5 \text{ pF}$$

$$\therefore C_{substrate} = 6.5 \text{ pF}$$

$$(f) I_S = \frac{q n_i^2}{Q_B / D_n} A_{EB}$$

From text example,

$$\begin{aligned} \frac{Q_B}{D_n} &= 5.7 \times 10^{11} \text{ cm}^{-4} \text{ sec} \\ \therefore I_S &= \frac{1.6 \times 10^{-19} \times 2 \times 10^{20} \times 1600 \text{ cm}^2 \times (10^{-8} \frac{\text{cm}^2}{\text{mm}^2})}{5.7 \times 10^{11}} \\ &= 0.9 \times 10^{-15} \text{ A} \end{aligned}$$

2.7

From (2.24), the β falloff begins at $I_E = q A N_D \frac{D_p}{W_B}$

For this structure, the area A is the product of the emitter diffusion periphery $120 \mu\text{m}$, and the effective sidewall depth.

Regarding the sidewall as a quarter-cylinder this effective depth is the emitter junction depth multiplied by $\pi/2$. Thus,

$$A_{eff} = (120 \mu\text{m})(3 \mu\text{m})(\pi/2) = 5.65 \times 10^{-6} \text{ cm}^2$$

From Fig.(2.2), the donor density corresponding to a resistivity of $0.5 \Omega\text{-cm}$ is $1.2 \times 10^{16} \text{ cm}^{-3}$. Thus,

$$\begin{aligned} I_C &= \frac{(1.6 \times 10^{-19})(5.65 \times 10^{-6})(1.2 \times 10^{16})(10)}{8 \times 10^{-4}} \\ &= 13.56 \times 10^{-5} = 136 \mu\text{A} \end{aligned}$$

2.8

From (2.17), for a pnp transistor

$$Q_B = q A D_p \frac{n_i^2}{I_c} \exp\left(\frac{V_{BE}}{V_T}\right)$$

For this device,

$$\begin{aligned} A &= 2 \times (30 \mu\text{m} \times 75 \mu\text{m}) + 2 \times (10 \mu\text{m} \times 30 \mu\text{m}) \\ &= 5100 \mu\text{m}^2 \end{aligned}$$

For $V_{BE} = 525 \text{ mV}$

$$\begin{aligned} Q_B &= \frac{1.6 \times 10^{-19} \times 5100 \times 10^{-6} \times 10 \times 2 \times 10^{20}}{10^{-5}} \exp\left(\frac{525}{26}\right) \\ &= 9.6 \times 10^{11} \end{aligned}$$

Using Fig.(2.2), the donor density corresponding to $2 \Omega\text{-cm}$ is $2.5 \times 10^{15} \text{ cm}^{-3}$

since, $Q_B = W_B N_D$, then

$$\begin{aligned} W_B &= \frac{Q_B}{N_D} = \frac{9.6 \times 10^{11}}{2.5 \times 10^{15}} = 3.84 \times 10^{-4} \text{ cm} \\ &= 3.84 \mu\text{m} \end{aligned}$$

Since the p-diffusion depth is $3 \mu\text{m}$, the total epi thickness is $6.84 \mu\text{m}$, for $V_{BE} = 525 \text{ mV}$. By a similar calculation, the total depth for $V_{BE} = 560 \text{ mV}$ is $17.45 \mu\text{m}$.

The same resistances are :

For $V_{BE} = 525 \text{ mV}$

$$\begin{aligned} R_D &= [q \bar{D}_n Q_B]^{-1} \\ &= [(1.6 \times 10^{-19})(800)(9.6 \times 10^{11})]^{-1} \\ &= [12 \times 10^{-5}]^{-1} = 8 \text{ k}\Omega/\square \end{aligned}$$

For $V_{BE} = 560 \text{ mV}$

$$R_D = 2.12 \text{ k}\Omega/\square$$

2.9

First consider the $6 \mu\text{m}$ resistor,

For $10 \text{ k}\Omega$ we need 100 squares or $600 \mu\text{m}$ of length. The total

resistor area is that of the body plus clubheads, or

$$A_{\text{bottom}} = 600 \mu\text{m} \times 6 \mu\text{m} + 2(26 \mu\text{m})^2 \\ = 4952 (\mu\text{m})^2$$

The sidewall area is equal to the total periphery multiplied by $(3 \mu\text{m})(\frac{\pi}{2})$.

The periphery is,

$$P = 600 \mu\text{m} + 600 \mu\text{m} + 6 \times 26 \mu\text{m} + \\ 2(26 - 6) \mu\text{m} \\ = 1396 \mu\text{m}$$

Thus,

$$A_{\text{sidewall}} = 1396 \mu\text{m} \times 3 \mu\text{m} \times \frac{\pi}{2} \\ = 6578 (\mu\text{m})^2$$

The total area is,

$$A_{\text{total}} = 11,530 (\mu\text{m})^2$$

For the 10^{15} cm^{-3} epi concentration the capacitance per unit area for zero bias is from Fig.(2.29) equal to $10^{-4} \text{ PF}/(\mu\text{m})^2$

$$\text{thus, } C_{\text{total}} = 11,530 (\mu\text{m})^2 \times 10^{-4} \frac{\text{PF}}{(\mu\text{m})^2} \\ = 1.15 \text{ pF}$$

For the $12 \mu\text{m}$ resistor, we need $1200 \mu\text{m}$ of length.

$$\text{thus, } A_{\text{bottom}} = 12 \mu\text{m} \times 1200 \mu\text{m} + 2(26 \mu\text{m})^2 \\ = 15,750 (\mu\text{m})^2$$

$$A_{\text{sidewall}} = \frac{\pi}{2} [1200 \times 2 + 26 \times 6 + \\ 2(26 - 12)] \times 3 \\ = 12,177 (\mu\text{m})^2$$

$$\therefore A_{\text{total}} = 27,929 (\mu\text{m})^2$$

$$\therefore C_{\text{total}} = 27,929 (\mu\text{m})^2 \times 10^{-4} \frac{\text{PF}}{(\mu\text{m})^2} = 2.8 \text{ pF}$$

2.10

$$(1) I_S = A_{EB} q n_i^2 \bar{D}_{Pb} Q_B \\ = [90 \mu\text{m} \times 75 \mu\text{m} - 30 \mu\text{m} \times 55 \mu\text{m}] \\ \times 10^{-8} \frac{\text{cm}^2}{\mu^2} \times \frac{(1.6 \times 10^{-19})(2 \times 10^{20}) (10 \text{ cm}^2/\text{sec})}{(10^{15} \frac{\text{atoms}}{\text{cm}^3}) \times 14 \mu\text{m} \times 10^{-4} \frac{\text{cm}}{\mu\text{m}}} \\ = 1.17 \times 10^{-14} \text{ A}$$

$$(2) C_{je} = A_{\text{bottom}} \times 10^{-4} \frac{\text{pF}}{(\mu\text{m})^2} \\ + A_{\text{sidewall}} \times 10^{-3} \frac{\text{pF}}{(\mu\text{m})^2} \\ = (90 \times 75 - 30 \times 55) (\mu\text{m})^2 \times 10^{-4} \frac{\text{pF}}{(\mu\text{m})^2} \\ + \frac{\pi}{2} (60 + 110) (3) (\mu\text{m})^2 \times 10^{-3} \frac{\text{pF}}{(\mu\text{m})^2} \\ = 0.51 + 0.8 = 1.31 \text{ pF}$$

$$(3) C_M = C_{\text{epi-sidewall}} + C_{\text{bottom}}$$

$$= \frac{\pi}{2} (40 \times 2 + 125 \times 2) \times (17) (\mu\text{m})^2 \times 10^{-4} \frac{\text{pF}}{(\mu\text{m})^2} \\ + (140 \times 125) (\mu\text{m})^2 \times 10^{-4} \frac{\text{pF}}{(\mu\text{m})^2} \\ = 1.4 + 1.75 = 3.15 \text{ pF}$$

$$(4) T_F = \frac{W_B^2}{2 D_p} = \frac{[(14 \mu\text{m})(10^{-4} \text{ cm}/\mu\text{m})]^2}{2 \times 10 \text{ cm}^2/\text{sec}} \\ = 98 \text{ nsec}$$

2.11

For an npn transistor

$$Q_B = \frac{q A \bar{D}_n n_i^2}{I_C} \exp\left(\frac{V_{BE}}{V_T}\right) \\ = \frac{(1.6 \times 10^{-19})(10^{-4} \text{ cm}^2)(13)(2 \times 10^{20})}{10^{-5}} e^{\frac{480}{26}} \\ = 4.3 \times 10^{11} \text{ atoms/cm}^2$$

$$R_\square = [q \mu_p Q_B]^{-1} \\ = [1.6 \times 10^{-19} \times 150 \frac{\text{cm}^2}{\text{V-sec}} \times 4.3 \times 10^{11}]^{-1} \\ = 97 \text{ k}\Omega/\square$$

In order to contain 4.3×10^{11} atoms/cm² of the n-type epi-impurity, the width of the collector depletion layer at punch-thru is,

$$W_D = \frac{4.3 \times 10^{11} \text{ atoms/cm}^2}{10^{15} \text{ cm}^{-3}} = 4.3 \times 10^{-4} \text{ cm} = 4.3 \mu\text{m}$$

Using (1.15) and assuming that

$N_A \gg N_D$,

$$W_D = \sqrt{\frac{2\varepsilon(4\phi_f + V_R)}{qN_D}} = 4.3 \mu\text{m}$$

$$= \sqrt{\frac{2 \times 1.04 \times 10^{12} \times (0.55 + V_R)}{1.6 \times 10^{-19} \times 10^{15}}} \text{ cm}$$

$$\therefore V_R = 13.7 \text{ V}$$

For $V_{BE} = 560 \text{ mV}$, same expressions give, $Q_B = 9.4 \times 10^{12} \text{ atoms/cm}^2$

$$R_D = 4.43 \text{ k}\Omega/\square$$

$$W_D = 94 \mu\text{m}$$

$$V_R = 6.796 \text{ V}$$

2.12

From (1.157),

$$I_D = \frac{MnC_{ox}}{2} \frac{W}{L} (V_{GS} - V_t)^2$$

$$100 \text{ mA} = \frac{MnC_{ox}}{2} \frac{W}{L} (1.5 - V_t)^2 \rightarrow (1)$$

$$10 \text{ mA} = \frac{MnC_{ox}}{2} \frac{W}{L} (0.8 - V_t)^2 \rightarrow (2)$$

Divide (1) by (2) and solve for $V_t \rightarrow$ gives $V_t = 0.48 \text{ V}$.

Substituting for V_t in (1) gives,

$$MnC_{ox} \frac{W}{L} = 191 \text{ mA/V}$$

$$2.13 \quad V_t = \phi_{MS} + 2\phi_f + \frac{Q_b}{C_{ox}} - \frac{Q_{ss}}{C_{ox}}, \quad (2.27)$$

(i) For unimplanted transistors, From Table 2.1, $\phi_{MS} = -0.1 \text{ V}$

From (2.28),

$$\phi_f = \frac{kT}{q} \ln \frac{N_A}{n_i} = 0.026 \ln \frac{10^{16}}{1.45 \times 10^{10}} = 0.35.$$

From (2.30),

$$C_{ox} = 0.86 \text{ fF}/(\mu\text{m})^2$$

$$\frac{Q_{ss}}{C_{ox}} = \frac{1.6 \times 10^{-19} \times 10^{11}}{8.6 \times 10^{-8}} = 0.19 \text{ V}$$

From (1.137),

$$Q_{bo} = \sqrt{2qN_A \varepsilon \cdot 2\phi_f} = [2 \times 1.6 \times 10^{-19} \times 10^{16} \times 11.6 \times 8.86 \times 10^{-14} \times 2 \times 0.35]^{\frac{1}{2}} = 4.8 \times 10^{-8} \text{ coulombs/cm}^2$$

$$\therefore V_t = -0.1 - 2 \times 0.35 - \frac{4.8 \times 10^{-8}}{8.6 \times 10^{-8}} - 0.19 = -1.55$$

(ii) For implanted transistors,

$$N_A = 1 \times 10^{16} - 0.9 \times 10^{16} = 10^{15} \text{ cm}^{-3}$$

From Fig.(2.29), the depletion layer width corresponding to a doping level of 10^{15} cm^{-3} is $\sim 1 \mu\text{m}$, while the implant depth is only $0.3 \mu\text{m}$

$$\therefore V_{t(\text{implant})} = -1.55$$

$$+ \frac{0.9 \times 10^{16} \times 0.3 \times 10^{-4} \times 1.6 \times 10^{-19}}{8.6 \times 10^{-8}}$$

$$= -1.05$$

2.14

The metallurgical channel length is

$$L = L_{\text{drawn}} - 2L_d = 7.4 \mu\text{m} - 2(0.3) = 6.4 \mu\text{m}$$

The effective channel length is L minus the width of the depletion region at the drain. In the active region, the voltage at the drain end of the channel is $= V_{GS} - V_t = V_{ov}$. To calculate V_{ov} , assume at first that $L_{eff} \approx L$. Then from (1.166)

$$V_{ov} = \sqrt{\frac{2I_D}{k'W_L}} = \sqrt{\frac{2(10 \text{ mA})}{700 \frac{\text{cm}^2}{\text{V.s}} \cdot 0.86 \frac{\text{FF}}{\mu^2} \left(\frac{100}{6.4}\right)}} = 0.15 \text{ V}$$

Thus, the voltage across the drain depletion region $= 5 - 0.15 = 4.85 \text{ V}$

To estimate the depletion-region width, assume it is a one-sided step junction that mainly exists in the lightly doped side. Since the channel and the drain are both n-type regions, the built-in potential of the junction is near zero. Using (1.14) and assuming $N_D \gg N_A$,

$$x_d = \sqrt{\frac{2\epsilon(V_{DS} - V_{ov})}{qN_A}} = \sqrt{\frac{2(1.04 \times 10^{12})(5 - 0.15)}{1.6 \times 10^{19}(2 \times 10^{16} + 10^{15})}} = 0.55 \mu\text{m}$$

$$\text{So, } L_{eff} = 7 \mu\text{m} - 2(0.3 \mu\text{m}) - 0.55 \mu\text{m} = 5.85 \mu\text{m}$$

Therefore, since $r_o = \frac{1}{\lambda I_D} = \frac{L_{eff}}{I_D} / \frac{dx_d}{dV_{DS}}$

$$\Rightarrow r_o = 5 \text{ M}\Omega = \frac{5.85 \mu\text{m}}{10 \text{ mA}} / \frac{dx_d}{dV_{DS}}$$

So, $\frac{dx_d}{dV_{DS}} = 0.12 \frac{\mu\text{m}}{\text{V}}$. Since, the other device uses the same technology, $\frac{dx_d}{dV_{DS}}$ is unchanged. But, should calculate V_{ov} for 2nd transistor,

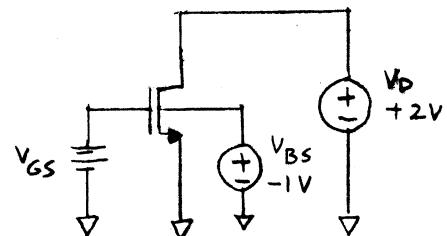
$$V_{ov} = \sqrt{\frac{2I}{k'W}} = \sqrt{\frac{2(30)}{(60.2) \frac{50}{12-2(0.3)}}} = 0.48 \text{ V}$$

$$\text{So, } x_d = \sqrt{\frac{2(1.04 \times 10^{12})(5 - 0.48)}{1.6 \times 10^{19}(2.1 \times 10^{16})}} = 0.53 \mu\text{m}$$

$$L_{eff_2} = 12 - 2(0.3) - 0.53 = 10.87 \mu\text{m}$$

$$r_o = \frac{L_{eff}}{I_D} / \frac{dx_d}{dV_{DS}} = \frac{10.87 \mu\text{m}}{30 \text{ mA}} / 0.12 = 3.02 \text{ M}\Omega$$

Note that using the same V_{ov} as for the 1st transistor (0.15 V) gives an answer of 3.1 M Ω . (The change hardly matters)

2.15

First to estimate x_d and L_{eff}

$$L_{eff} = L_{\text{drawn}} - 2L_d - x_d \rightarrow (1)$$

$$x_d = \sqrt{\frac{2\epsilon_s(V_{DS} - V_{ov})}{q(N_A + N_i)}} \rightarrow (2)$$

$$I_D = \frac{MnC_{ox}}{2} \frac{W}{L_{eff}} (V_{GS} - V_t)^2 \rightarrow (3)$$

L_{eff} , x_d and $(V_{GS} - V_t)$ can be

found by solving (1), (2), (3).

To avoid solving non-linear equations, the following procedure is used: find x_d by substituting $L_{\text{drawn}} - 2L_D$ for L_{eff} in (3) and use the result in (2).

From (3),

$$\begin{aligned} V_{GS} - V_t &= \sqrt{\frac{2I_D}{M_n C_{ox} W/L_{\text{eff}}}} \\ &= \sqrt{\frac{2 \times 20 \mu A}{450 \frac{\text{cm}^2}{\text{V.sec}} 4.32 \frac{\text{fF}}{(\mu\text{m})^2} \left(\frac{10 \mu\text{m}}{1 \mu\text{m} - 2(0.09 \mu\text{m})} \right)}} \\ &= 0.130 \text{ V} \end{aligned}$$

From (2),

$$\begin{aligned} x_d &= \sqrt{\frac{2 \times 11.6 \times 8.86 \times 10^{-14} (2 - 0.13)}{1.6 \times 10^{-19} (5 \times 10^{15} + 4 \times 10^{16})}} \\ &= 0.231 \mu\text{m} \end{aligned}$$

From (1),

$$\begin{aligned} L_{\text{eff}} &\approx 1 \mu\text{m} - 2(0.09 \mu\text{m}) - 0.231 \mu\text{m} \\ &= 0.589 \mu\text{m} \end{aligned}$$

$$\begin{aligned} (a) \quad g_m &= \sqrt{\frac{2K' W}{L_{\text{eff}}} I_D} \\ &= \sqrt{\frac{2 \times 194 \frac{\mu\text{A}}{\text{V}^2} \times 10}{0.589} \times 20 \mu\text{A}} \\ &= 363 \frac{\mu\text{A}}{\text{V}} \end{aligned}$$

$$(b) \quad \text{From (1.200), } g_{mb} = \frac{\gamma g_m}{2 \sqrt{2\phi_f + V_{SB}}}$$

$$\text{where, } \gamma = \frac{\sqrt{2q \epsilon_{si} N_T}}{C_{ox}} \quad \text{and}$$

N_T is the effective dopant density at the bottom of the channel-substrate depletion layer, it can be

either N_A (substrate doping) or $N_A + N_i$. To determine which one applies, we have to find $x'_d \max$, i.e., the depletion depth under the channel,

$$x'_d \max = \sqrt{\frac{2 \epsilon_{si} (2|\phi_f| + V_{SB})}{q (N_A + N_i)}}$$

But,

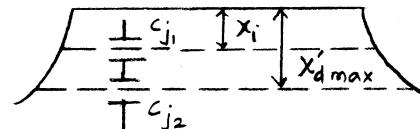
$$\begin{aligned} \phi_f &= \frac{kT}{q} \ln \frac{N_A + N_i}{N_i} \\ &= 0.026 \ln \frac{4 \times 10^{16} + 5 \times 10^{15}}{1.45 \times 10^{10}} = 0.389 \end{aligned}$$

$$\therefore x'_d \max = \sqrt{\frac{2 \times 11.6 \times 8.86 \times 10^{-14} (2 \times 0.389 + 1)}{1.6 \times 10^{-19} (4 \times 10^{16} + 5 \times 10^{15})}}$$

$$= 0.225 \mu\text{m}$$

$> 0.16 \mu\text{m}$ (effective implant depth)

since $x'_d \max > x_i$, the depletion capacitor is the series combination of the capacitors as shown,



Now χ can be calculated from the following relationships,

$$\chi = \frac{C_{js}}{C_{ox}}, \quad C_{js} = \frac{C_{j1} C_{j2}}{C_{j1} + C_{j2}}$$

$$C_{j1} = \frac{\epsilon_{si}}{x_i}, \quad C_{j2} = \frac{\epsilon_{si}}{x'_d \max - x_i}$$

The actual depletion depth is

$$x_{d\max.} = \left[\frac{2 \epsilon_{Si}}{q N_A} (\phi_f + |\phi_p| + V_{SB} - x_i^2 \frac{N_i}{N_A}) \right]^{\frac{1}{2}}$$

(cf. Muller and Kamins : Device Electronics for Integrated Circuits, 2nd ed., 1986; equation (10.6.2))

$$\phi_f = \frac{kT}{q} \ln \frac{N_A}{N_i} = 0.026 \ln \frac{5 \times 10^5}{1.45 \times 10^{10}} = 0.33 \text{ V}$$

$$x_{d\max.} = \left[\frac{2 \times 11.6 \times 8.86 \times 10^{-4}}{1.6 \times 10^{-19} \times 5 \times 10^{15}} (0.33 + 0.389 + 1) - \frac{(0.16 \times 10^{-4} \text{ cm})^2 (4 \times 10^{16})}{5 \times 10^{15}} \right]^{\frac{1}{2}} \\ = 0.453 \text{ } \mu\text{m}$$

$$C_{j1} = \frac{11.6 \times 8.86 \times 10^{-4}}{0.16 \times 10^{-4}} = 6.42 \times 10^{-8} \text{ F/cm}^2$$

$$C_{j2} = \frac{11.6 \times 8.86 \times 10^{-4}}{(0.453 - 0.16) \times 10^{-4}} = 3.51 \times 10^{-8} \text{ F/cm}^2$$

$$C_{js} = 2.27 \times 10^{-8} \text{ F/cm}^2$$

$$\therefore x = \frac{2.27 \times 10^{-8}}{4.32 \times 10^{-7}} = 0.0526$$

$$g_{mb} = x g_m = 0.0526 \times 363 \times 10^{-6} = 19.1 \frac{\text{mA}}{\text{V}}$$

(c) From (2.37),

$$V_{ov} = \sqrt{\frac{2 I_D}{k' (W/L_{eff})}} = \sqrt{\frac{2 \times 20 \text{ mA}}{194 \text{ mA/V}^2 (10 \mu\text{m}/0.589 \mu\text{m})}} \\ = 0.110 \text{ V}$$

$$x_d = \sqrt{\frac{2 \epsilon_{Si} (V_{DS} - V_{ov})}{q (N_A + N_i)}}$$

$$\frac{dx_d}{dV_{DS}} = \frac{x_d}{2(V_{DS} - V_{ov})} = \frac{0.231 \mu\text{m}}{2(2 - 0.11)} = 0.061 \mu\text{m/V}$$

$$\therefore Y_0 = \left(\frac{I_D}{L_{eff}} \frac{dx_d}{dV_{DS}} \right)^{-1} = \left(\frac{20 \text{ mA}}{0.589 \mu\text{m}} \times 0.061 \mu\text{m/V} \right)^{-1} \\ = 482.78 \text{ k}\Omega$$

$$(d) C_{gs} = \frac{2}{3} W L_{eff} C_{ox} + C_{OL}$$

$$= \frac{2}{3} \times 10 \times 0.589 \times 4.32 \times 10^{-15} \\ + 0.35 \times 10^{-15} \times 10 \\ = 20.5 \text{ fF}$$

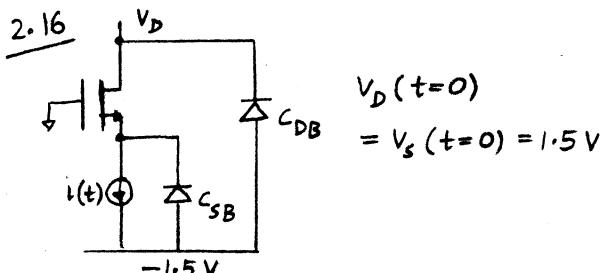
$$(e) C_{gd} = C_{OL} = 0.35 \times 10^{-15} \times 10 = 3.5 \text{ fF}$$

$$(f) C_{db} = \frac{C_{jo} \times (\text{drain area}) + C_{jswo} \times \text{periphery}}{\sqrt{1 + V_{DB}/\phi_0}}$$

$$= \frac{0.2 \times 10 \times 1 + 1.2 (10 + 1 \times 2)}{\sqrt{1 + (3/0.7)}} \text{ fF} \\ = 7.1 \text{ fF}$$

$$(g) C_{sb} = \frac{C_{jo} \times (\text{source area}) + C_{jswo} \times \text{periphery}}{\sqrt{1 + V_{SB}/\phi_0}}$$

$$= \frac{0.2 \times 10 \times 1 + 1.2 (10 + 1 \times 2)}{\sqrt{1 + (1/0.7)}} \text{ fF} \\ = 10.5 \text{ fF}$$



(i) Initially transistor is off, current source discharges $C_{OL} + C_{SB}$. The rate of voltage change is,

$$\frac{V}{t} = \frac{I}{C}$$

$$\approx \frac{10 \text{ mA}}{10 \mu\text{sec}}$$

$$0.35 \frac{\text{fF}}{\mu\text{m}} \times 10 \mu\text{m} + 0.2 \frac{\text{fF}}{\mu\text{m}^2} \times 10 \mu\text{m} \times (1 \mu\text{m} \\ + 0.09 \mu\text{m}) + 1.2 \frac{\text{fF}}{\mu\text{m}} (12 \mu\text{m}) \\ = 500 \frac{\text{V}}{\mu\text{sec}}$$

(ii) Transistor enters saturation region ; drain current starts to flow , discharges $C_{OL} + C_{DB}$ and $\frac{2}{3} C_{ox} WL + C_{OL} + C_{SB}$. The discharge rate of drain voltage is

$$\frac{V}{t} \approx \frac{10 \text{ mA}}{C_{OL} + C_{DB}}$$

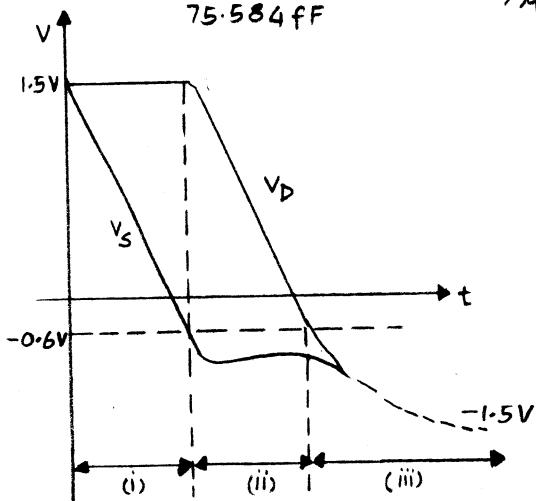
$$= \frac{10 \text{ mA}}{\frac{0.35 \frac{fF}{4m} \times 10 \mu m + 0.2 \frac{fF}{4m^2} \times 10 \mu m \times (1 \mu m + 0.09 \mu m)}{4m} + 1.2 \frac{fF}{4m} (12 \mu m)}$$

$$= 500 \text{ V/}\mu\text{s}$$

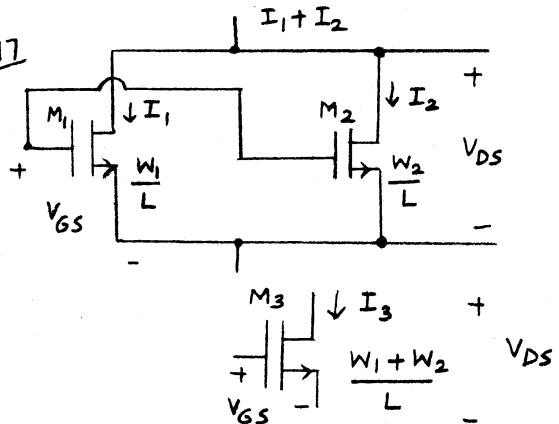
(iii) Transistor enters triode region, current discharges $C_{ox} WL + C_{DB} + C_{SB} + 2 C_{OL}$ at a rate of,

$$\frac{V}{t} \approx \frac{10 \text{ mA}}{\{4.32(10)(1-2(0.09)) + 0.2(10)(1+0.09)\} 2 + 1.2(12) 2 + \underbrace{0.35(2)(10)}_{2 \text{ overlaps}}}$$

$$= \frac{10 \text{ mA}}{75.584 \text{ fF}} = 132.30 \text{ V/}\mu\text{s}$$



2.17



Note that all the transistors have equal terminal voltages. So,

$$V_{GS_1} = V_{GS_2} = V_{GS_3} = V_{GS}$$

$$V_{DS_1} = V_{DS_2} = V_{DS_3} = V_{DS}$$

$$V_{SB_1} = V_{SB_2} = V_{SB_3} = V_{SB}$$

If $V_{SB} \neq 0$, there is a body effect

$$\text{but } V_{t_1} = V_{t_2} = V_{t_3} = V_t$$

Case 1 : All active

$$I_1 = \frac{k'}{2} \frac{W_1}{L} (V_{GS} - V_t)^2 (1 + \gamma V_{DS})$$

$$I_2 = \frac{k'}{2} \frac{W_2}{L} (V_{GS} - V_t)^2 (1 + \gamma V_{DS})$$

$$I_1 + I_2 = \frac{k'}{2} \left(\frac{W_1 + W_2}{L} \right) (V_{GS} - V_t)^2 (1 + \gamma V_{DS})$$

$$I_3 = \frac{k'}{2} \left(\frac{W_1 + W_2}{L} \right) (V_{GS} - V_t)^2 (1 + \gamma V_{DS}) \\ = I_1 + I_2$$

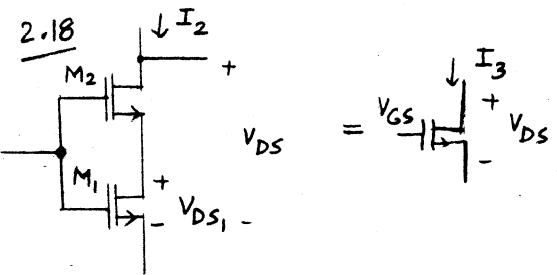
Case 2 : All triode

$$I_1 = \frac{k'}{2} \frac{W_1}{L} [2(V_{GS} - V_t)V_{DS} - V_{DS}^2]$$

$$I_2 = \frac{k'}{2} \frac{W_2}{L} [2(V_{GS} - V_t)V_{DS} - V_{DS}^2]$$

$$I_1 + I_2 = \frac{k'}{2} \left(\frac{W_1 + W_2}{L} \right) [2(V_{GS} - V_t)V_{DS} - V_{DS}^2]$$

$$I_3 = \frac{k'}{2} \left(\frac{W_1 + W_2}{L} \right) [2(V_{GS} - V_t)V_{DS} - V_{DS}^2] \\ = I_1 + I_2$$



M₂ can operate in active or triode region. M₁ always operates in triode region.

$$I_1 = \frac{k'}{2} \left(\frac{W}{L} \right)_1 [2(V_{GS} - V_t) V_{DS1} - V_{DS1}^2] = I_2$$

Solve for V_{DS1},

$$V_{DS1}^2 - 2(V_{GS} - V_t)V_{DS1} + \frac{2I_2}{k' \left(\frac{W}{L} \right)_1} = 0$$

$$V_{DS1} = \frac{2(V_{GS} - V_t) \pm \sqrt{4(V_{GS} - V_t)^2 - 4 \frac{2I_2}{k' \left(\frac{W}{L} \right)_1}}}{2}$$

V_{DS1} must be < V_{GS} - V_t or M₁ would be in active region.

$$V_{DS1} = V_{GS} - V_t - \sqrt{(V_{GS} - V_t)^2 - \frac{2I_2}{k' \left(\frac{W}{L} \right)_1}}$$

Assume M₂ is active,

$$\begin{aligned} I_2 &= \frac{k'}{2} \left(\frac{W}{L} \right)_2 (V_{GS} - V_{DS1} - V_t)^2 \\ &= \frac{k'}{2} \left(\frac{W}{L} \right)_2 \left[V_{GS} - V_t - (V_{GS} - V_t) + \sqrt{(V_{GS} - V_t)^2 - \frac{2I_2}{k' \left(\frac{W}{L} \right)_1}} \right]^2 \\ &= \frac{k'}{2} \left(\frac{W}{L} \right)_2 (V_{GS} - V_t)^2 - \left(\frac{W}{L} \right)_2 \frac{I_2}{\left(\frac{W}{L} \right)_1} \end{aligned}$$

$$I_2 \left(1 + \left(\frac{W}{L} \right)_2 / \left(\frac{W}{L} \right)_1 \right) = \frac{k'}{2} \left(\frac{W}{L} \right)_2 (V_{GS} - V_t)^2$$

$$\begin{aligned} I_2 &= \left[\frac{k'}{2} \left\{ \left(\frac{W}{L} \right)_2 / \left(1 + \left(\frac{W}{L} \right)_2 / \left(\frac{W}{L} \right)_1 \right) \right\} \right] (V_{GS} - V_t)^2 \\ &= \frac{k'}{2} \left(\frac{W}{L_1 + L_2} \right) (V_{GS} - V_t)^2 \end{aligned}$$

If M₂ and M₃ are active,

$$I_3 = \frac{k'}{2} \left(\frac{W}{L_1 + L_2} \right) (V_{GS} - V_t)^2 = I_2$$

Assume M₂ is in triode region,

$$\begin{aligned} I_2 &= \frac{k'}{2} \left(\frac{W}{L} \right)_2 \left[2(V_{GS} - V_{DS1} - V_t)(V_{DS} - V_{DS1}) \right. \\ &\quad \left. - (V_{DS} - V_{DS1})^2 \right] \end{aligned}$$

$$V_{DS1} = V_{GS} - V_t - \sqrt{(V_{GS} - V_t)^2 - \frac{2I_2}{k' \left(\frac{W}{L} \right)_1}}$$

$$\begin{aligned} I_2 &= \frac{k'}{2} \left(\frac{W}{L} \right)_2 \left[2 \sqrt{(V_{GS} - V_t)^2 - \frac{I_2}{k' \left(\frac{W}{L} \right)_1}} \right] \left[V_{DS} - \right. \\ &\quad \left. (V_{GS} - V_t) + \sqrt{(V_{GS} - V_t)^2 - \frac{2I_2}{k' \left(\frac{W}{L} \right)_1}} \right] - \\ &\quad \left[V_{DS} - (V_{GS} - V_t) + \sqrt{(V_{GS} - V_t)^2 - \frac{2I_2}{k' \left(\frac{W}{L} \right)_1}} \right]^2 \} \end{aligned}$$

Let X = V_{DS} - (V_{GS} - V_t) and

$$Y = \sqrt{(V_{GS} - V_t)^2 - \frac{I_2}{k' \left(\frac{W}{L} \right)_1}}$$

Then,

$$I_2 = \frac{k'}{2} \left(\frac{W}{L} \right)_2 [2Y(x+Y) - (x+Y)^2]$$

$$I_2 = \frac{k'}{2} \left(\frac{W}{L} \right)_2 [2XY + 2Y^2 - X^2 - Y^2 - 2XY]$$

$$I_2 = \frac{k'}{2} \left(\frac{W}{L} \right)_2 [Y^2 - X^2]$$

$$\begin{aligned} &= \frac{k'}{2} \left(\frac{W}{L} \right)_2 \left[(V_{GS} - V_t)^2 - \frac{I_2}{k' \left(\frac{W}{L} \right)_1} - \right. \\ &\quad \left. \{ V_{DS} - (V_{GS} - V_t) \}^2 \right] \end{aligned}$$

$$\begin{aligned} &= \frac{k'}{2} \left(\frac{W}{L} \right)_2 \left[(V_{GS} - V_t)^2 - \frac{I_2}{k' \left(\frac{W}{L} \right)_1} - \right. \\ &\quad \left. V_{DS}^2 - 2V_{DS}(V_{GS} - V_t) + (V_{GS} - V_t)^2 \right] \end{aligned}$$

$$I_2 \left(1 + \left(\frac{W}{L} \right)_2 \right) = \frac{k'}{2} \left(\frac{W}{L} \right)_2 \left\{ -V_{DS}^2 + \right. \\ &\quad \left. \left(\frac{W}{L} \right)_1 2V_{DS}(V_{GS} - V_t) \right\}$$

$$\begin{aligned} I_2 &= \frac{k'}{2} \frac{W}{L_1 + L_2} \left[2(V_{GS} - V_t)V_{DS} - V_{DS}^2 \right] \\ &= I_3 \end{aligned}$$

2.19(a) Curve B ;(i) The cost of a 40,000 mil² chip is

$$C = \frac{C_W}{(N Y_{ws}) Y_{df} Y_{ft}} = \frac{100}{(47)(0.9)(0.8)} + \frac{0.6}{0.8}$$

$$= 3.71$$

 $N Y_{ws} = 47$ is obtained from fig.(2.70)(ii) The cost of two 20,000 mil² chips is,

$$C_{Y_2} = \frac{100}{(200)(0.9)(0.8)} + \frac{0.6}{0.8} = 1.44$$

$$C_{\text{total}} = C_{1/2} \times 2 = 2.88$$

\therefore Putting the system on two chips is more economical

(b) Curve A ;(i) For a 40,000 mil² chip,

$$C = \frac{100}{(115)(0.9)(0.8)} + \frac{0.6}{0.8} = 1.1$$

$$C_{\text{total}} = 1.1 \times 2 = 2.2$$

\therefore one chip is more economical

(c) Curve C :(i) For a 40,000 mil² chip,

$$C = \frac{100}{12(0.9)(0.8)} + \frac{0.6}{0.8} = 12.3$$

(ii) For two 20,000 mil² chips,

$$C_{1/2} = \frac{100}{(80)(0.9)(0.8)} + \frac{0.6}{0.8} = 2.49$$

$$C_{\text{total}} = 2.49 \times 2 = 4.98$$

\therefore using two chips is more economical

2.20

$$\text{Area} = (150 \text{ mils})^2 = 22,500 \text{ mil}^2$$

(a) Curve A ,

$$C = \frac{C_W}{(N Y_{ws})(Y_{df})(Y_{ft})} + \frac{C_P}{Y_{ft}}$$

$$= \frac{130}{(360)(0.8)(0.8)} + \frac{0.4}{0.8} = 1.06$$

$N Y_{ws} = 360$ is obtained from Fig.(2.70)

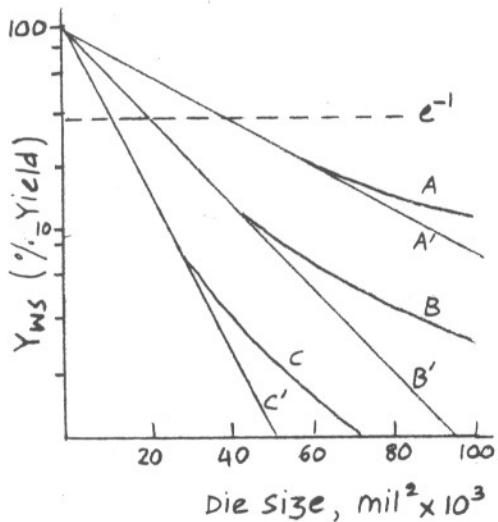
(b) Curve B,

$$C = \frac{130}{(140)(0.8)(0.8)} + \frac{0.4}{0.8} = 1.95$$

(c) Curve C,

$$C = \frac{130}{(60)(0.8)(0.8)} + \frac{0.4}{0.8} = 3.89$$

2.21

(a) When $Y_{ws} = e^{-1} = 0.37$ From curve A, $A_0 = 38,000 \text{ mil}^2$ curve B, $A_0 = 20,000 \text{ mil}^2$ curve C, $A_0 = 11,000 \text{ mil}^2$ 

Curves A', B' and C' are predicted by the equation.

(b) In fig (2.69), gross die/wafer is inversely proportional to the die size, i.e., $N = KA^{-1}$, K is the proportionality constant related to the wafer size (more specifically, K is the effective or usable area on the wafer). By (2.56), the cost per unit silicon area is,

$$\frac{C}{A} = \frac{C_w}{AN Y_{ws} Y_{df} Y_{ft}} + \frac{C_p}{AY_{ft}}$$

$$= \frac{C_w}{K e^{-N/A_0} Y_{df} Y_{ft}} + \frac{C_p}{AY_{ft}}$$

Each K can be obtained from fig (2.69). e.g. $K = 1.15 \times 10^5 \text{ mil}^2$ for 4" wafer.

2.22

First estimate x_d and L_{eff}

$$L_{eff} = L_{drawn} - 2L_d - x_d \quad (1)$$

$$x_d = \sqrt{\frac{2\epsilon_{si}(V_{DS} - V_{ov})}{q(N_A + N_i)}} \quad (2)$$

$$I_D = \frac{k'_n}{2} \frac{W}{L_{eff}} (V_{GS} - V_t)^2 \quad (3)$$

x_d , L_{eff} and $V_{ov} = V_{GS} - V_t$ can be found by solving equations (1), (2) and (3). However, solving these nonlinear equations is difficult. Instead, we approximately solve them. First, estimate x_d by substituting $L_{drawn} - 2L_d$ for L_{eff} in (3) and use that result in (2).

From (3) and using values in Table 2.5:

$$\begin{aligned} V_{ov} &= V_{GS} - V_t = \sqrt{\frac{2I_D}{k'_n W / L_{eff}}} \\ &\approx \sqrt{\frac{2(100\mu A)}{(246\frac{\mu A}{V^2}) \frac{0.9\mu m}{0.2\mu m - 2(0.01\mu m)}}} \\ &= 0.40V \end{aligned}$$

where $k'_n = \mu_n C_{ox} = 300 \frac{cm^2}{V \cdot s} (8.21 \frac{fF}{\mu m^2}) \frac{10^4 \mu m}{1cm} = 246 \mu A/V^2$ and $C_{ox} = 8.21 \frac{fF}{\mu m^2}$ (based on $t_{ox} = 42$ Angstroms) have been used.

Using (2) and $V_{DS} = 1.0$ V:

$$\begin{aligned} x_d &= \sqrt{\frac{2(11.6)(8.86 \times 10^{-14})(1 - 0.40)}{1.6 \times 10^{-19}(8 \times 10^{16} + 1 \times 10^{17})}} \text{ cm} \\ &= 0.065 \mu m \end{aligned}$$

From (1),

$$L_{eff} = 0.2\mu m - 2(0.01\mu m) - 0.065\mu m \approx 0.12\mu m$$

Now we can calculate g_m :

$$\begin{aligned} g_m &= \sqrt{2k'_n(W/L_{eff})I_D} \\ &= \sqrt{2(246\mu A/V^2)(0.9/0.12)100\mu A} \\ &= 607\mu A/V \end{aligned}$$

Next we find r_o :

$$\begin{aligned} r_o &= [(I_D/L_{eff})\partial x_d/\partial V_{DS}]^{-1} \\ &= [(100\mu A/0.12\mu m)0.028\mu m/V]^{-1} \\ &= 43k\Omega \end{aligned}$$

Since the transistor is active (or saturated):

$$\begin{aligned} C_{gs} &= \frac{2}{3}WL_{eff}C_{ox} + C_{ol} \\ &= \frac{2}{3}(0.9\mu m)(0.12\mu m)8.21fF/\mu m^2 \\ &\quad + (0.9\mu m)0.36fF/\mu m \\ &= 0.59fF + 0.32fF = 0.91fF \end{aligned}$$

and

$$\begin{aligned} C_{gd} &= C_{ol} \\ &= (0.9\mu m)0.36fF/\mu m \\ &= 0.32fF \end{aligned}$$

2.23

First estimate x_d and L_{eff}

$$L_{eff} = L_{drawn} - 2L_d - x_d \quad (1)$$

$$x_d = \sqrt{\frac{2\epsilon_{si}(V_{DS} - V_{ov})}{q(N_A + N_i)}} \quad (2)$$

$$I_D = \frac{k'_n}{2} \frac{W}{L_{eff}} (V_{GS} - V_t)^2 \quad (3)$$

x_d , L_{eff} and $V_{ov} = V_{GS} - V_t$ can be found by solving equations (1), (2) and (3). However, solving these nonlinear equations is difficult. Instead, we approximately solve them. First, estimate x_d by substituting $L_{drawn} - 2L_d$ for L_{eff} in (3) and use that result in (2).

From (3) and using values in Table 2.6:

$$\begin{aligned} V_{ov} &= V_{GS} - V_t = \sqrt{\frac{2I_D}{k'_n W / L_{eff}}} \\ &\approx \sqrt{\frac{2(100\mu A)}{(538\frac{\mu A}{V^2}) \frac{0.5\mu m}{0.1\mu m - 2(0.005\mu m)}}} \\ &= 0.27V \end{aligned}$$

where $k'_n = \mu_n C_{ox} = 390 \frac{cm^2}{V \cdot s} (\frac{13.8fF}{\mu m^2}) \frac{10^4 \mu m}{1cm} = 538\mu A/V^2$ and $C_{ox} = 13.8 \frac{fF}{\mu m^2}$ (based on $t_{ox} = 25$ Angstroms) have been used.

Using (2) and $V_{DS} = 0.6$ V:

$$\begin{aligned} x_d &= \sqrt{\frac{2(11.6)(8.86 \times 10^{-14})(0.6 - 0.27)}{1.6 \times 10^{-19}(1 \times 10^{17} + 5 \times 10^{17})}} \text{ cm} \\ &= 0.027\mu m \end{aligned}$$

From (1),

$$L_{eff} = 0.1\mu m - 2(0.005\mu m) - 0.027\mu m = 0.063\mu m$$

Now we can find g_m :

$$\begin{aligned} g_m &= \sqrt{2k'_n(W/L_{eff})I_D} \\ &= \sqrt{2(538\mu A/V^2)(0.5/0.063)100\mu A} \\ &= 924\mu A/V \end{aligned}$$

Next we calculate r_o :

$$\begin{aligned} r_o &= [(I_D/L_{eff})\partial x_d/\partial V_{DS}]^{-1} \\ &= [(100\mu A/0.063\mu m)0.06\mu m/V]^{-1} \\ &= 10.5k\Omega \end{aligned}$$

Since the transistor is active (or saturated):

$$\begin{aligned} C_{gs} &= \frac{2}{3}WL_{eff}C_{ox} + C_{ol} \\ &= \frac{2}{3}(0.5\mu m)(0.063\mu m)13.8fF/\mu m^2 \\ &\quad + (0.5\mu m)0.10fF/\mu m \\ &= 0.29fF + 0.05fF = 0.34fF \end{aligned}$$

and

$$\begin{aligned} C_{gd} &= C_{ol} \\ &= (0.5\mu m)0.10fF/\mu m \\ &= 0.05fF \end{aligned}$$

The gate-leakage current can be estimated by

$$\begin{aligned} I_G &\approx J_G WL \\ &\approx (1.2 \text{ nA}/\mu m^2)(0.50\mu m)[0.1\mu m - 2(0.005\mu m)] \\ &= 54pA \end{aligned}$$